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LF198/LF298/LF398, LF198A/LF398A Monolithic Sample-and-Hold Circuits

General Description

The LF198/LF298/LF398 are monolithic sample-and-hold circuits which utilize BI-FET technology to obtain ultra-high dc accuracy with fast acquisition of signal and low droop rate. Operating as a unity gain follower, dc gain accuracy is 0.002% typical and acquisition time is as low as 6 μs to 0.01%. A bipolar input stage is used to achieve low offset voltage and wide bandwidth. Input offset adjust is accomplished with a single pin, and does not degrade input offset drift. The wide bandwidth allows the LF198 to be included inside the feedback loop of 1 MHz op amps without having stability problems. Input impedance of $10^{10}\Omega$ allows high source impedances to be used without degrading accuracy. P-channel junction FET's are combined with bipolar devices in the output amplifier to give droop rates as low as 5 mV/min with a 1 μF hold capacitor. The JFET's have much lower noise than MOS devices used in previous designs and do not exhibit high temperature instabilities. The overall design guarantees no feed-through from input to output in the hold mode, even for input signals equal to the supply voltages.

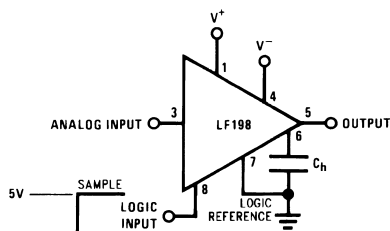
Features

- Operates from $\pm 5\text{V}$ to $\pm 18\text{V}$ supplies
- Less than 10 μs acquisition time
- TTL, PMOS, CMOS compatible logic input
- 0.5 mV typical hold step at $C_h = 0.01 \mu\text{F}$
- Low input offset
- 0.002% gain accuracy
- Low output noise in hold mode
- Input characteristics do not change during hold mode
- High supply rejection ratio in sample or hold
- Wide bandwidth
- Space qualified, JM38510

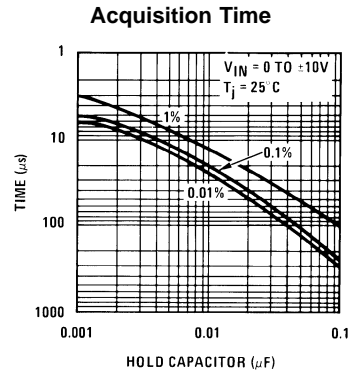
Logic inputs on the LF198 are fully differential with low input current, allowing direct connection to TTL, PMOS, and CMOS. Differential threshold is 1.4V. The LF198 will operate from $\pm 5\text{V}$ to $\pm 18\text{V}$ supplies.

An "A" version is available with tightened electrical specifications.

Typical Connection and Performance Curve

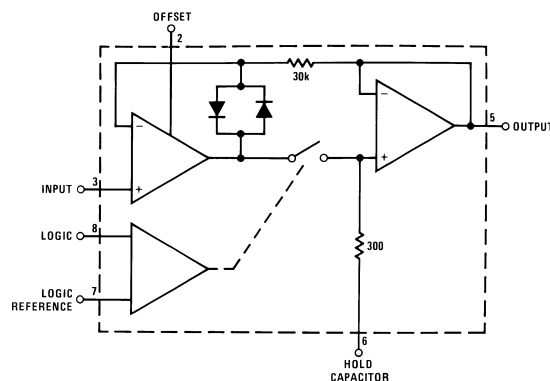


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Functional Diagram



DS005692-1

Absolute Maximum Ratings (Note 1)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

Supply Voltage	±18V
Power Dissipation (Package Limitation) (Note 2)	500 mW
Operating Ambient Temperature Range	
LF198/LF198A	-55°C to +125°C
LF298	-25°C to +85°C
LF398/LF398A	0°C to +70°C
Storage Temperature Range	-65°C to +150°C
Input Voltage	Equal to Supply Voltage
Logic To Logic Reference	
Differential Voltage (Note 3)	+7V, -30V
Output Short Circuit Duration	Indefinite

Hold Capacitor Short

Circuit Duration 10 sec

Lead Temperature (Note 4)

H package (Soldering, 10 sec.) 260°C

N package (Soldering, 10 sec.) 260°C

M package:

Vapor Phase (60 sec.) 215°C

Infrared (15 sec.) 220°C

Thermal Resistance (θ_{JA}) (typicals)

H package 215°C/W (Board mount in still air)

85°C/W (Board mount in

400LF/min air flow)

N package 115°C/W

M package 106°C/W

θ_{JC} (H package, typical) 20°C/W

Electrical Characteristics

The following specifications apply for $-V_S + 3.5V \leq V_{IN} \leq +V_S - 3.5V$, $+V_S = +15V$, $-V_S = -15V$, $T_A = T_j = 25^\circ\text{C}$, $C_h = 0.01 \mu\text{F}$, $R_L = 10 \text{ k}\Omega$, LOGIC REFERENCE = 0V, LOGIC HIGH = 2.5V, LOGIC LOW = 0V unless otherwise specified.

Parameter	Conditions	LF198/LF298			LF398			Units
		Min	Typ	Max	Min	Typ	Max	
Input Offset Voltage, (Note 5)	$T_j = 25^\circ\text{C}$		1	3		2	7	mV
	Full Temperature Range			5			10	mV
Input Bias Current, (Note 5)	$T_j = 25^\circ\text{C}$		5	25		10	50	nA
	Full Temperature Range			75			100	nA
Input Impedance	$T_j = 25^\circ\text{C}$		10^{10}			10^{10}		Ω
Gain Error	$T_j = 25^\circ\text{C}$, $R_L = 10\text{k}$		0.002	0.005		0.004	0.01	%
	Full Temperature Range			0.02			0.02	%
Feedthrough Attenuation Ratio at 1 kHz	$T_j = 25^\circ\text{C}$, $C_h = 0.01 \mu\text{F}$	86	96		80	90		dB
Output Impedance	$T_j = 25^\circ\text{C}$, "HOLD" mode		0.5	2		0.5	4	Ω
	Full Temperature Range			4			6	Ω
"HOLD" Step, (Note 6)	$T_j = 25^\circ\text{C}$, $C_h = 0.01 \mu\text{F}$, $V_{OUT} = 0$		0.5	2.0		1.0	2.5	mV
Supply Current, (Note 5)	$T_j \geq 25^\circ\text{C}$		4.5	5.5		4.5	6.5	mA
Logic and Logic Reference Input Current	$T_j = 25^\circ\text{C}$		2	10		2	10	μA
Leakage Current into Hold Capacitor (Note 5)	$T_j = 25^\circ\text{C}$, (Note 7) Hold Mode		30	100		30	200	μA
Acquisition Time to 0.1%	$\Delta V_{OUT} = 10\text{V}$, $C_h = 1000 \text{ pF}$		4			4		μs
	$C_h = 0.01 \mu\text{F}$		20			20		μs
Hold Capacitor Charging Current	$V_{IN} - V_{OUT} = 2\text{V}$		5			5		mA
Supply Voltage Rejection Ratio	$V_{OUT} = 0$	80	110		80	110		dB
Differential Logic Threshold	$T_j = 25^\circ\text{C}$	0.8	1.4	2.4	0.8	1.4	2.4	V
Input Offset Voltage, (Note 5)	$T_j = 25^\circ\text{C}$		1	1		2	2	mV
	Full Temperature Range			2			3	mV
Input Bias Current, (Note 5)	$T_j = 25^\circ\text{C}$		5	25		10	25	nA
	Full Temperature Range			75			50	nA

Electrical Characteristics

The following specifications apply for $-V_S + 3.5V \leq V_{IN} \leq +V_S - 3.5V$, $+V_S = +15V$, $-V_S = -15V$, $T_A = T_J = 25^\circ C$, $C_h = 0.01 \mu F$, $R_L = 10 k\Omega$, LOGIC REFERENCE = 0V, LOGIC HIGH = 2.5V, LOGIC LOW = 0V unless otherwise specified.

Parameter	Conditions	LF198A			LF398A			Units
		Min	Typ	Max	Min	Typ	Max	
Input Impedance	$T_J = 25^\circ C$		10^{10}			10^{10}		Ω
Gain Error	$T_J = 25^\circ C$, $R_L = 10k$ Full Temperature Range		0.002	0.005		0.004	0.005	% %
Feedthrough Attenuation Ratio at 1 kHz	$T_J = 25^\circ C$, $C_h = 0.01 \mu F$	86	96		86	90		dB
Output Impedance	$T_J = 25^\circ C$, "HOLD" mode Full Temperature Range		0.5	1		0.5	1	Ω Ω
"HOLD" Step, (Note 6)	$T_J = 25^\circ C$, $C_h = 0.01 \mu F$, $V_{OUT} = 0$		0.5	1		1.0	1	mV
Supply Current, (Note 5)	$T_J \geq 25^\circ C$		4.5	5.5		4.5	6.5	mA
Logic and Logic Reference Input Current	$T_J = 25^\circ C$		2	10		2	10	μA
Leakage Current into Hold Capacitor (Note 5)	$T_J = 25^\circ C$, (Note 7) Hold Mode		30	100		30	100	μA
Acquisition Time to 0.1%	$\Delta V_{OUT} = 10V$, $C_h = 1000 pF$ $C_h = 0.01 \mu F$		4	6		4	6	μs μs
Hold Capacitor Charging Current	$V_{IN} - V_{OUT} = 2V$		5			5		mA
Supply Voltage Rejection Ratio	$V_{OUT} = 0$	90	110		90	110		dB
Differential Logic Threshold	$T_J = 25^\circ C$	0.8	1.4	2.4	0.8	1.4	2.4	V

Note 1: "Absolute Maximum Ratings" indicate limits beyond which damage to the device may occur. Operating Ratings indicate conditions for which the device is functional, but do not guarantee specific performance limits.

Note 2: The maximum power dissipation must be derated at elevated temperatures and is dictated by T_{JMAX} , θ_{JA} , and the ambient temperature, T_A . The maximum allowable power dissipation at any temperature is $P_D = (T_{JMAX} - T_A)/\theta_{JA}$, or the number given in the Absolute Maximum Ratings, whichever is lower. The maximum junction temperature, T_{JMAX} , for the LF198/LF198A is $150^\circ C$; for the LF298, $115^\circ C$; and for the LF398/LF398A, $100^\circ C$.

Note 3: Although the differential voltage may not exceed the limits given, the common-mode voltage on the logic pins may be equal to the supply voltages without causing damage to the circuit. For proper logic operation, however, one of the logic pins must always be at least 2V below the positive supply and 3V above the negative supply.

Note 4: See AN-450 "Surface Mounting Methods and their effects on Product Reliability" for other methods of soldering surface mount devices.

Note 5: These parameters guaranteed over a supply voltage range of ± 5 to $\pm 18V$, and an input range of $-V_S + 3.5V \leq V_{IN} \leq +V_S - 3.5V$.

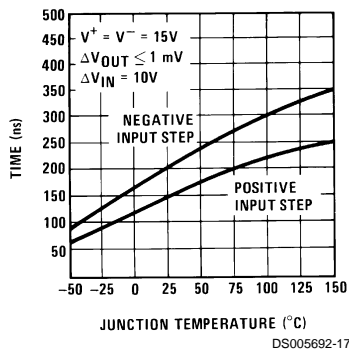
Note 6: Hold step is sensitive to stray capacitive coupling between input logic signals and the hold capacitor. 1 pF, for instance, will create an additional 0.5 mV step with a 5V logic swing and a 0.01 μF hold capacitor. Magnitude of the hold step is inversely proportional to hold capacitor value.

Note 7: Leakage current is measured at a junction temperature of $25^\circ C$. The effects of junction temperature rise due to power dissipation or elevated ambient can be calculated by doubling the $25^\circ C$ value for each $11^\circ C$ increase in chip temperature. Leakage is guaranteed over full input signal range.

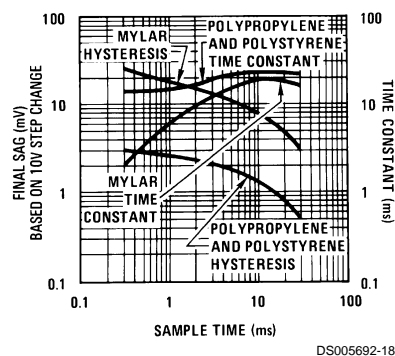
Note 8: A military RETS electrical test specification is available on request. The LF198 may also be procured to Standard Military Drawing #5962-8760801GA or to MIL-STD-38510 part ID JM38510/12501SGA.

Typical Performance Characteristics

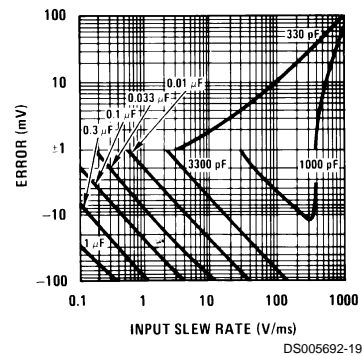
Aperture Time
(Note 9)



Dielectric Absorption Error in Hold Capacitor



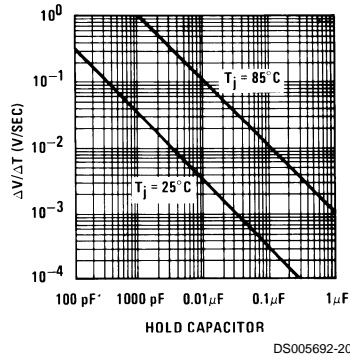
Dynamic Sampling Error



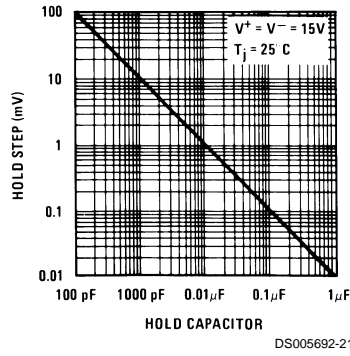
Note 9: See Definition of Terms

Typical Performance Characteristics (Continued)

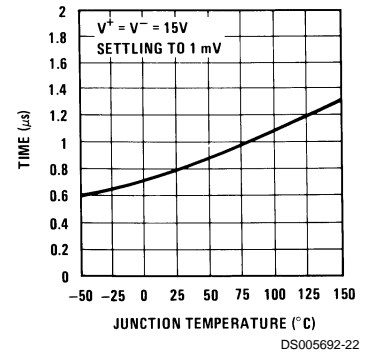
Output Droop Rate



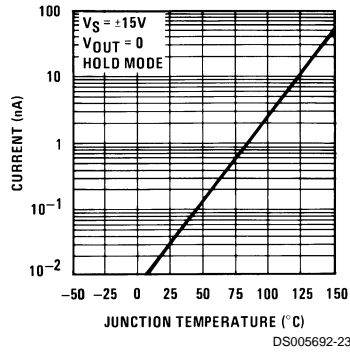
Hold Step



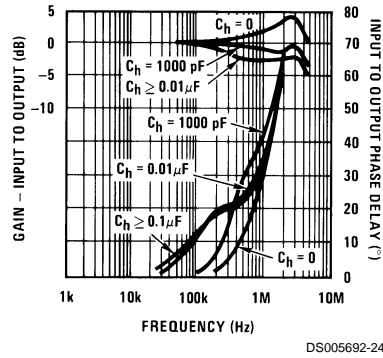
“Hold” Settling Time (Note 10)



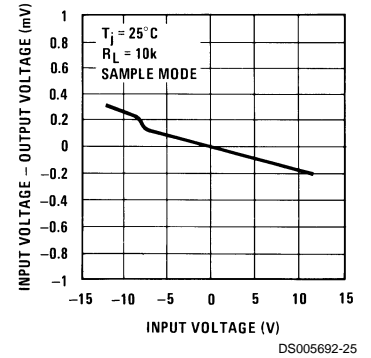
Leakage Current into Hold Capacitor



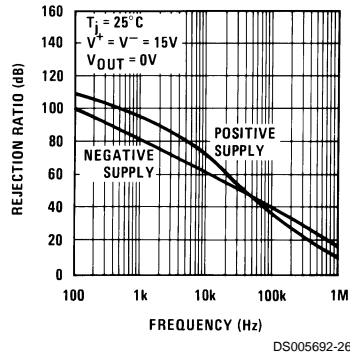
Phase and Gain (Input to Output, Small Signal)



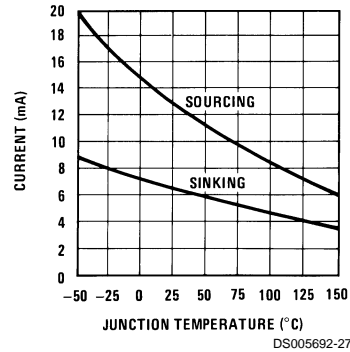
Gain Error



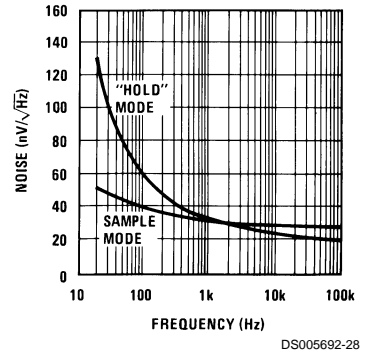
Power Supply Rejection



Output Short Circuit Current



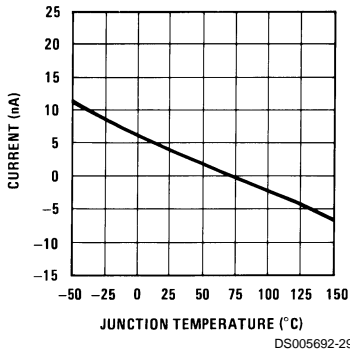
Output Noise



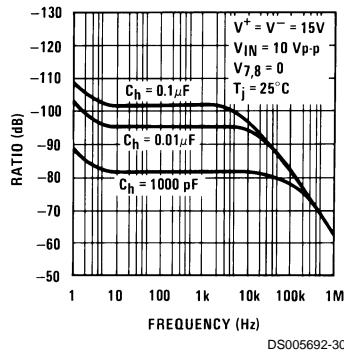
Note 10: See Definition

Typical Performance Characteristics (Continued)

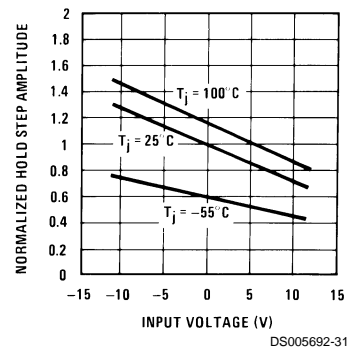
Input Bias Current



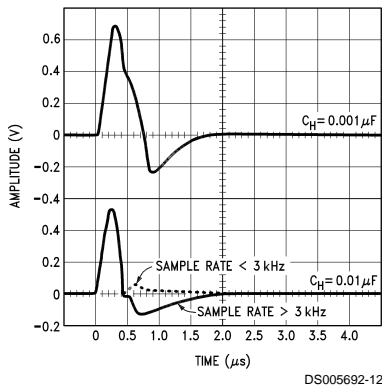
Feedthrough Rejection Ratio (Hold Mode)



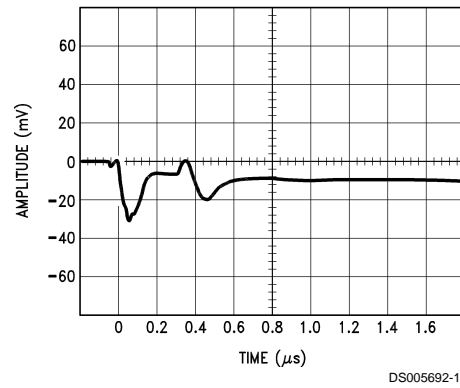
Hold Step vs Input Voltage



Output Transient at Start of Sample Mode

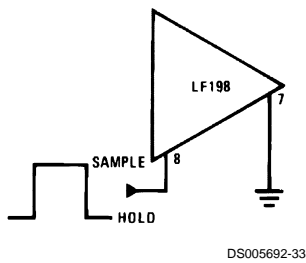


Output Transient at Start of Hold Mode

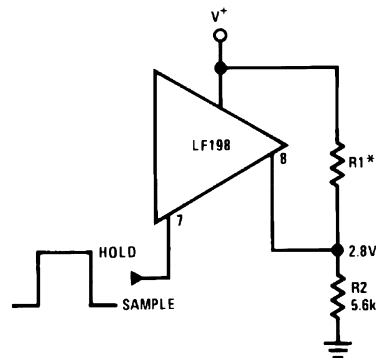


Logic Input Configurations

TTL & CMOS
 $3V \leq V_{LOGIC} (Hi State) \leq 7V$



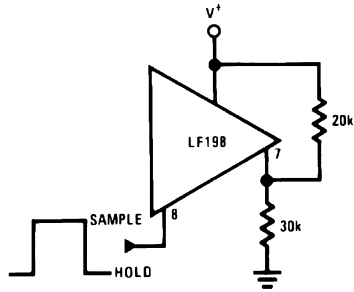
Threshold = 1.4V



Threshold = 1.4V
 *Select for 2.8V at pin 8

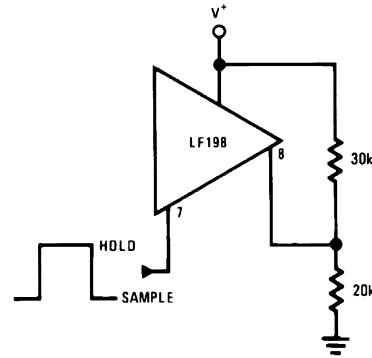
Logic Input Configurations (Continued)

CMOS
 $7V \leq V_{\text{LOGIC}} (\text{Hi State}) \leq 15V$



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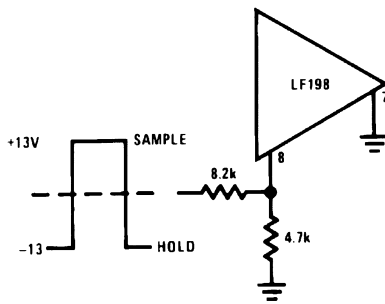
Threshold = $0.6 (V^+) + 1.4V$



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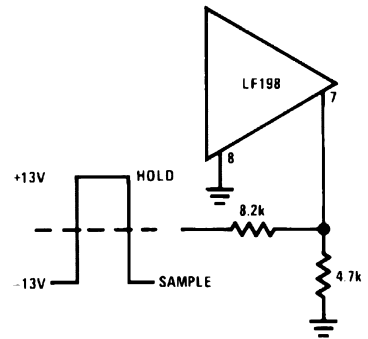
Threshold = $0.6 (V^+) - 1.4V$

Op Amp Drive



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Threshold = +4V



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Threshold = -4V

Application Hints

Hold Capacitor

Hold step, acquisition time, and droop rate are the major trade-offs in the selection of a hold capacitor value. Size and cost may also become important for larger values. Use of the curves included with this data sheet should be helpful in selecting a reasonable value of capacitance. Keep in mind that for fast repetition rates or tracking fast signals, the capacitor drive currents may cause a significant temperature rise in the LF198.

A significant source of error in an accurate sample and hold circuit is dielectric absorption in the hold capacitor. A mylar cap, for instance, may "sag back" up to 0.2% after a quick change in voltage. A long sample time is required before the circuit can be put back into the hold mode with this type of capacitor. Dielectrics with very low hysteresis are polystyrene, polypropylene, and Teflon. Other types such as mica and polycarbonate are not nearly as good. The advantage of polypropylene over polystyrene is that it extends the maximum ambient temperature from 85°C to 100°C. Most ceramic capacitors are unusable with > 1% hysteresis. Ceramic "NPO" or "COG" capacitors are now available for 125°C operation and also have low dielectric absorption. For more exact data, see the curve *Dielectric Absorption Error*. The hysteresis numbers on the curve are final values, taken after full relaxation. The hysteresis error can be significantly

reduced if the output of the LF198 is digitized quickly after the hold mode is initiated. The hysteresis relaxation time constant in polypropylene, for instance, is 10—50 ms. If A-to-D conversion can be made within 1 ms, hysteresis error will be reduced by a factor of ten.

DC and AC Zeroing

DC zeroing is accomplished by connecting the offset adjust pin to the wiper of a 1 kΩ potentiometer which has one end tied to V⁺ and the other end tied through a resistor to ground. The resistor should be selected to give ≈0.6 mA through the 1k potentiometer.

AC zeroing (hold step zeroing) can be obtained by adding an inverter with the adjustment pot tied input to output. A 10 pF capacitor from the wiper to the hold capacitor will give ±4 mV hold step adjustment with a 0.01 μF hold capacitor and 5V logic supply. For larger logic swings, a smaller capacitor (< 10 pF) may be used.

Logic Rise Time

For proper operation, logic signals into the LF198 must have a minimum dV/dt of 1.0 V/μs. Slower signals will cause excessive hold step. If a R/C network is used in front of the

Application Hints (Continued)

logic input for signal delay, calculate the slope of the waveform at the threshold point to ensure that it is at least $1.0 \text{ V}/\mu\text{s}$.

Sampling Dynamic Signals

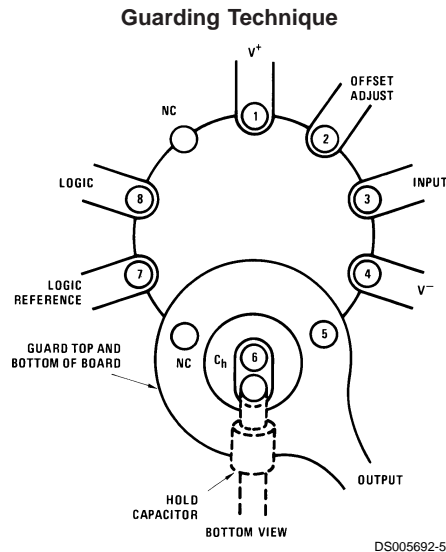
Sample error to moving input signals probably causes more confusion among sample-and-hold users than any other parameter. The primary reason for this is that many users make the assumption that the sample and hold amplifier is truly locked on to the input signal while in the sample mode. In actuality, there are finite phase delays through the circuit creating an input-output differential for fast moving signals. In addition, although the output may have settled, the hold capacitor has an additional lag due to the 300Ω series resistor on the chip. This means that at the moment the "hold" command arrives, the hold capacitor voltage may be somewhat different than the actual analog input. The effect of these delays is opposite to the effect created by delays in the logic which switches the circuit from sample to hold. For example, consider an analog input of 20 Vp-p at 10 kHz . Maximum dV/dt is $0.6 \text{ V}/\mu\text{s}$. With no analog phase delay and 100 ns logic delay, one could expect up to $(0.1 \mu\text{s}) (0.6 \text{ V}/\mu\text{s}) = 60 \text{ mV}$ error if the "hold" signal arrived near maximum dV/dt of the input. A positive-going input would give a $+60 \text{ mV}$ error. Now assume a 1 MHz (3 dB) bandwidth for the overall analog loop. This generates a phase delay of 160 ns . If the hold capacitor sees this exact delay, then error due to analog delay will be $(0.16 \mu\text{s}) (0.6 \text{ V}/\mu\text{s}) = -96 \text{ mV}$. Total output error is $+60 \text{ mV}$ (digital) -96 mV (analog) for a total of -36 mV . To add to the confusion, analog delay is proportioned to hold capacitor value while digital delay remains constant. A family of curves (dynamic sampling error) is included to help estimate errors.

A curve labeled *Aperture Time* has been included for sampling conditions where the input is steady during the sampling period, but may experience a sudden change nearly coincident with the "hold" command. This curve is based on a 1 mV error fed into the output.

A second curve, *Hold Settling Time* indicates the time required for the output to settle to 1 mV after the "hold" command.

Digital Feedthrough

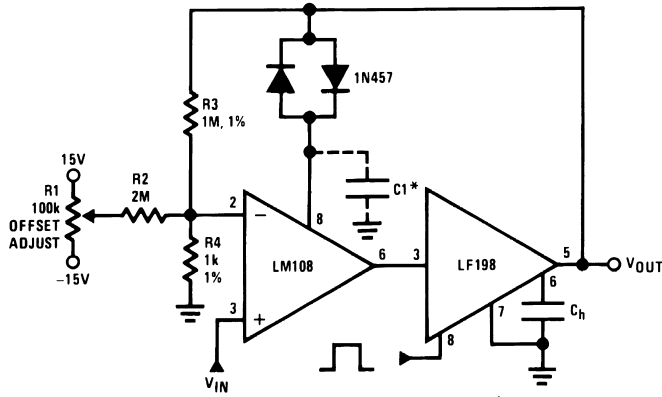
Fast rise time logic signals can cause hold errors by feeding externally into the analog input at the same time the amplifier is put into the hold mode. To minimize this problem, board layout should keep logic lines as far as possible from the analog input and the C_h pin. Grounded guarding traces may also be used around the input line, especially if it is driven from a high impedance source. Reducing high amplitude logic signals to 2.5 V will also help.



Use 10-pin layout. Guard around C_h is tied to output.

Typical Applications

X1000 Sample & Hold

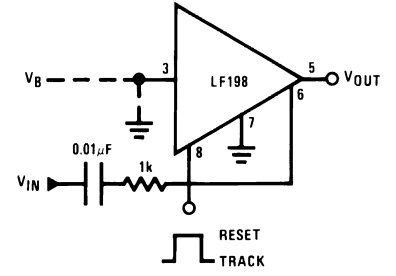


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*For lower gains, the LM108 must be frequency compensated

Use $\approx \frac{100}{A_v}$ pF from comp 2 to ground

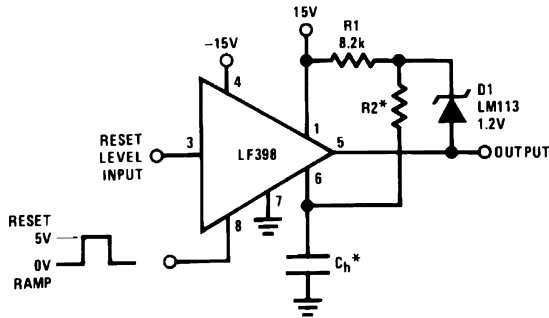
Sample and Difference Circuit
(Output Follows Input in Hold Mode)



DS005692-40

$$V_{OUT} = V_B + \Delta V_{IN}(\text{HOLD MODE})$$

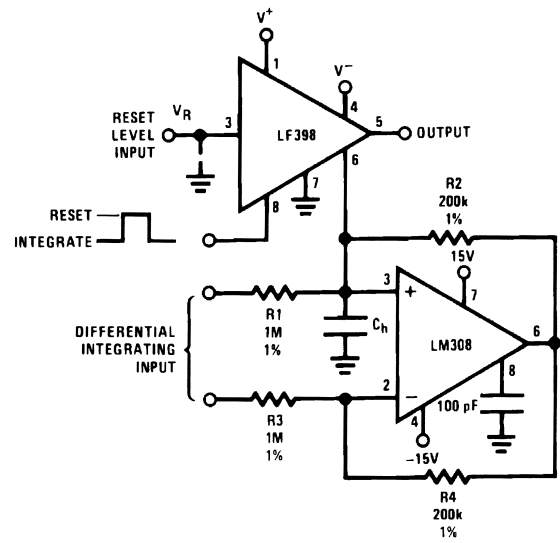
Ramp Generator with Variable Reset Level



DS005692-42

*Select for ramp rate $\frac{\Delta V}{\Delta T} = \frac{1.2V}{(R2)(C_h)}$
 $R2 \geq 10k$

Integrator with Programmable Reset Level

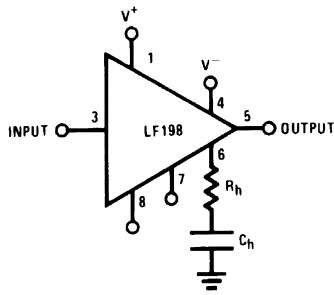


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$$V_{OUT}(\text{Hold Mode}) = \left[\frac{1}{(R1)(C_h)} \int_0^t V_{IN} dt \right] + [V_R]$$

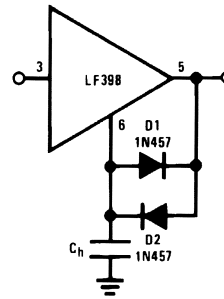
Typical Applications (Continued)

Output Holds at Average of Sampled Input



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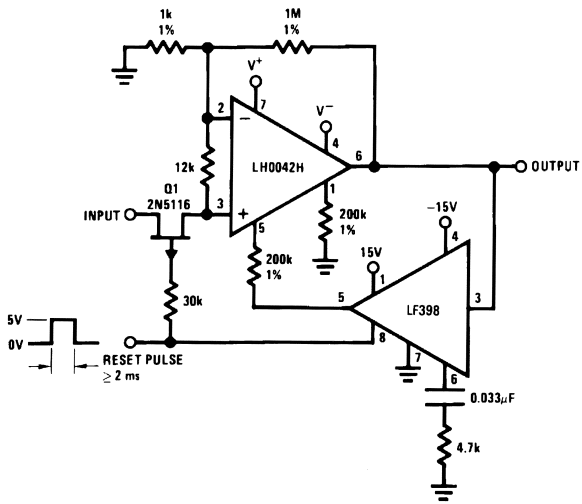
Increased Slew Current



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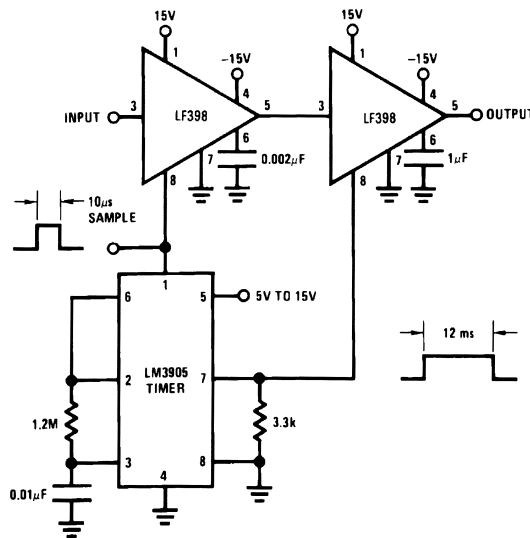
$$\text{Select } (R_h) (C_h) \gg \frac{1}{2\pi f_{IN} (\text{Min})}$$

Reset Stabilized Amplifier (Gain of 1000)



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Fast Acquisition, Low Droop Sample & Hold



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$$V_{OS} \leq 20\mu V \text{ (No trim)}$$

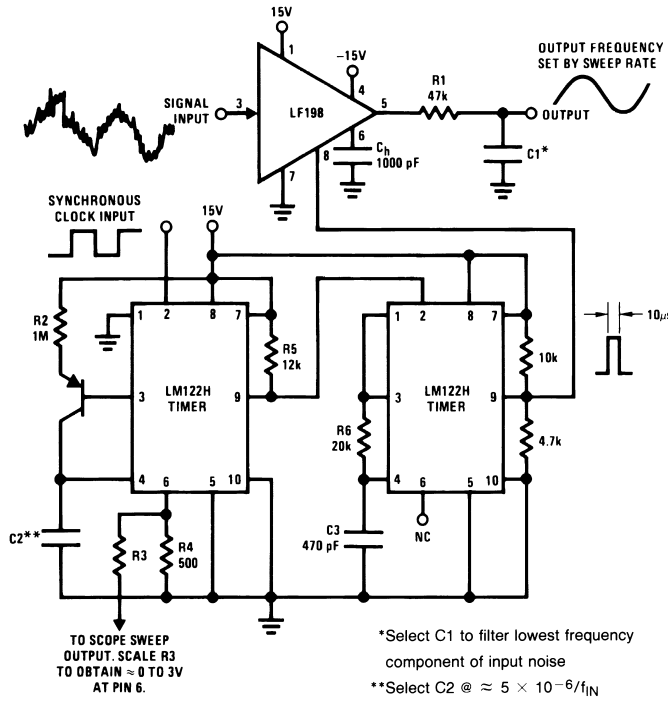
$$Z_{IN} \approx 1 \text{ M}\Omega$$

$$\frac{\Delta V_{OS}}{\Delta t} \approx 30\mu V/\text{sec}$$

$$\frac{\Delta V_{OS}}{\Delta T} \approx 0.1\mu V/^{\circ}\text{C}$$

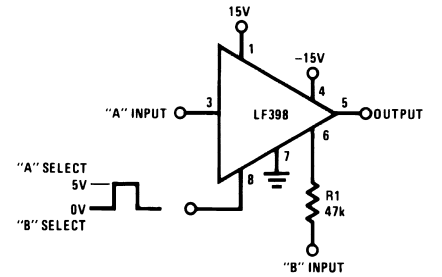
Typical Applications (Continued)

Synchronous Correlator for Recovering Signals Below Noise Level



DS005692-52

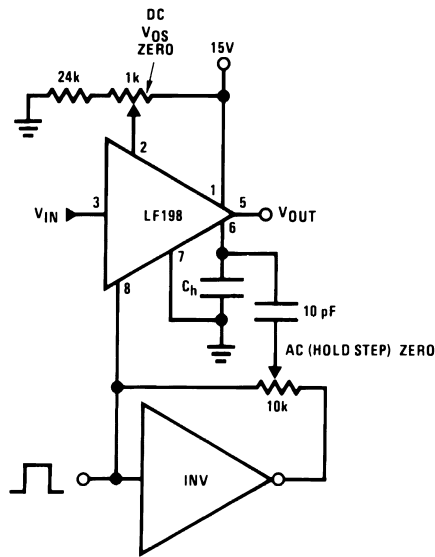
2-Channel Switch



DS005692-53

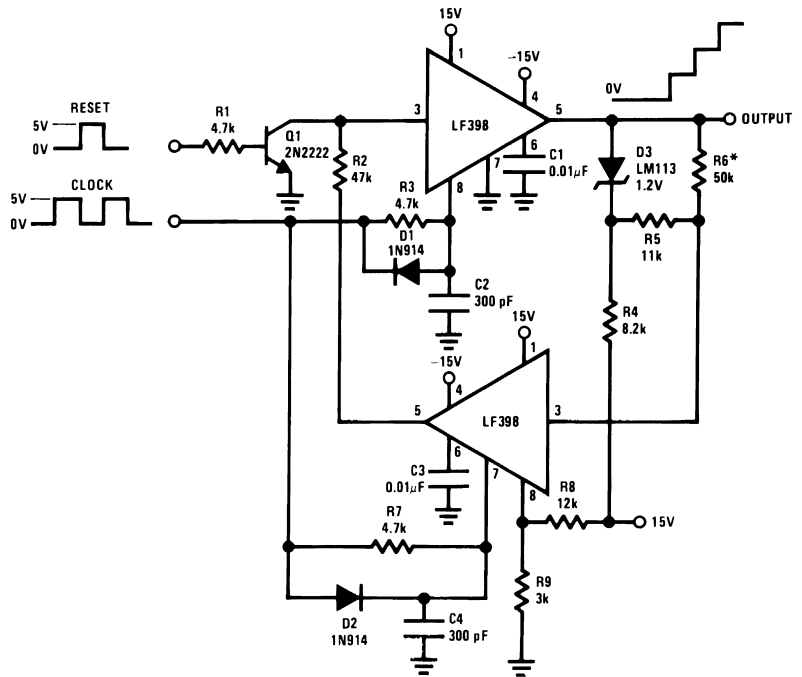
	A	B
Gain	$1 \pm 0.02\%$	$1 \pm 0.2\%$
Z_{IN}	$10^{10}\Omega$	47 k Ω
BW	≈ 1 MHz	≈ 400 kHz
Crosstalk @ 1 kHz	-90 dB	-90 dB
Offset	≤ 6 mV	≤ 75 mV

DC & AC Zeroing



DS005692-59

Staircase Generator

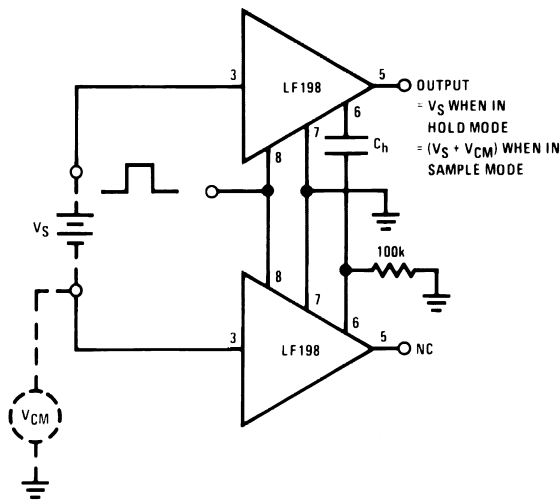


DS005692-55

*Select for step height 50k $\rightarrow \approx 1V$ Step

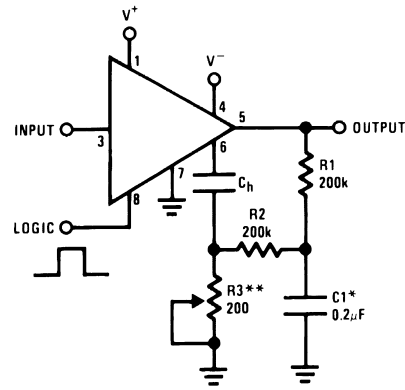
Typical Applications (Continued)

Differential Hold



DS005692-57

Capacitor Hysteresis Compensation



DS005692-56

*Select for time constant $C1 = \frac{\tau}{100k}$

**Adjust for amplitude

Definition of Terms

Hold Step: The voltage step at the output of the sample and hold when switching from sample mode to hold mode with a steady (dc) analog input voltage. Logic swing is 5V.

Acquisition Time: The time required to acquire a new analog input voltage with an output step of 10V. Note that acquisition time is not just the time required for the output to settle, but also includes the time required for all internal nodes to settle so that the output assumes the proper value when switched to the hold mode.

Gain Error: The ratio of output voltage swing to input voltage swing in the sample mode expressed as a per cent difference.

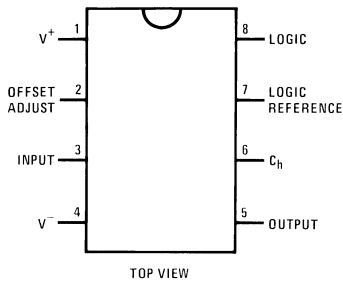
Hold Settling Time: The time required for the output to settle within 1 mV of final value after the "hold" logic command.

Dynamic Sampling Error: The error introduced into the held output due to a changing analog input at the time the hold command is given. Error is expressed in mV with a given hold capacitor value and input slew rate. Note that this error term occurs even for long sample times.

Aperture Time: The delay required between "Hold" command and an input analog transition, so that the transition does not affect the held output.

Connection Diagrams

Dual-In-Line Package

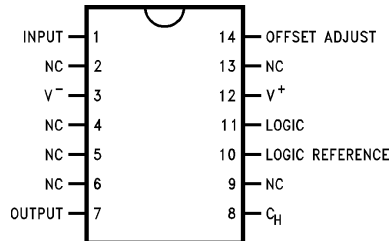


TOP VIEW

DS005692-11

**Order Number LF398N
or LF398AN
See NS Package Number N08E**

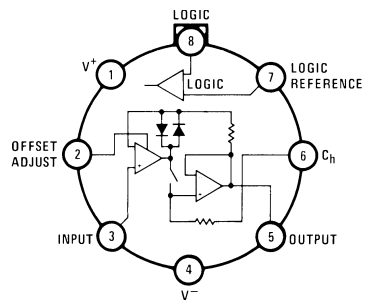
Small-Outline Package



DS005692-15

**Order Number LF298M or LF398M
See NS Package Number M14A**

Metal Can Package

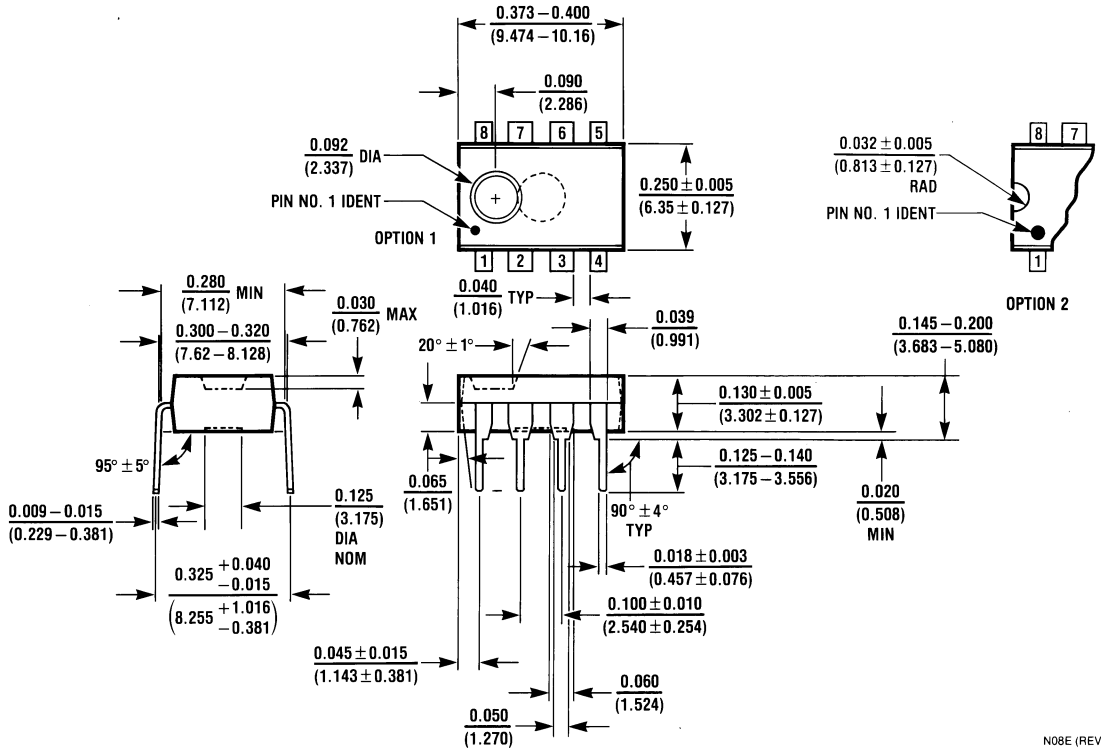


TOP VIEW

DS005692-14

**Order Number LF198H,
LF198H/883, LF298H,
LF398H, LF198AH or LF398AH
See NS Package Number H08C
(Note 8)**

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



Molded Dual-In-Line Package (N)
Order Number LF398N or LF398AN
NS Package Number N08E

N08E (REV F)

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LF398 - Monolithic Sample and Hold Circuit

- [Datasheet](#)
- [Packaging](#)
- [Samples & Pricing](#)
- [Reliability](#)
- [Application Notes](#)
- [Knowledge Base](#)

Features

Logic inputs on the LF198 are fully differential with low input current, allowing direct connection to TTL, PMOS, and CMOS. Differential threshold is 1.4V. The LF198 will operate from $\pm 5V$ to $\pm 18V$ supplies. An "A" version is available with tightened electrical specifications.

- Operates from $\pm 5V$ to $\pm 18V$ supplies
- Less than 10 μs acquisition time
- TTL, PMOS, CMOS compatible logic input
- 0.5 mV typical hold step at $C_h = 0.01 \mu F$
- Low input offset
- 0.002% gain accuracy
- Low output noise in hold mode
- Input characteristics do not change during hold mode
- High supply rejection ratio in sample or hold

General Description

The LF198/LF298/LF398 are monolithic sample-and-hold circuits which utilize BI-FET technology to obtain ultra-high dc accuracy with fast acquisition of signal and low droop rate. [More...](#)

Parameters	Values
Temperature Min	0 deg C
Temperature Max	70 deg C
Offset Voltage max, 25C	3, 10 mV

Additional Resources

- Wide bandwidth
- Space qualified, JM38510

Datasheet

 RoHS Compliance Information	Size in Kbytes	Date	
LF198/LF298/LF398, LF198A/LF398A Monolithic Sample-and-Hold Circuits	520 Kbytes	23-Aug-00	Download
LF198/LF298/LF398, LF198A/LF398A Monolithic Sample-and-Hold Circuits (Japanese) 本サイトの日本語版データシートは最新版ではない場合があります。ご検討およびご採用に当たっては、最新の英語版データシートを必ずご確認ください。	532 Kbytes		ダウンロード

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Package Availability, Models, Samples & Pricing

Part Number	Package							Factory Lead Time		Models	Samples & Electronic Orders	Budgetary Pricing		Std Pack Size	Package Marking Format
	Type	Pins	Spec.	MSL Rating	Peak Reflow	RoHS Report	CAD Symbols	Weeks	Qty			Qty	\$US each		
LF398M	SOIC NARROW	14	STD	1	235	RoHS	N/A	Full production		N/A	Samples Buy Now	1K+	\$0.68	rail of 55	NSUZXYTT LF398M
			NOPB	1	260			6 weeks	1000						
LF398MX	SOIC NARROW	14	STD	1	235	RoHS	N/A	Full production		N/A	Buy Now	1K+	\$0.68	reel of 2500	NSUZXYTT LF398M
			NOPB	1	260			6 weeks	3000						
LF398AN	MDIP	8	STD	1	NA	RoHS	N/A	Full production		N/A	Buy Now	1K+	\$1.42	rail of 40	NSUZXYTT LF398AN
			NOPB	1	NA			6 weeks	2000						
LF398N	MDIP	8	STD	1	NA	RoHS	N/A	Full production		N/A	Buy Now	1K+	\$0.66	rail of 40	NSUZXYTT LF398N
			NOPB	1	NA			16 weeks	5000						
LF398AH	TO-99	8	NOPB	1	NA	RoHS	N/A	Obsolete		N/A		1K+	\$5.00	box of 500	NSZXYTTE# LF398AH
								6 weeks	1000						
LF398H	TO-99	8	STD	1	NA	RoHS	N/A	Full production		N/A		1K+	\$4.21	box of	NSZXYTTE# LF398H

			NOPB	1	NA			6 weeks	1000		Buy Now			500	
LF398 MDC	Unpackaged Die						Custom		N/A				CALL	tray of N/A	-
							N/A	N/A							
LF398 MWC	Wafer						Obsolete		N/A				CALL	wafer jar of N/A	-
							N/A	40000							

Obsolete Versions

Obsolete Part	Alternate Part or Supplier	Source	Last Time Buy Date
LF398AH	LF198AH	NATIONAL SEMICONDUCTOR	03 Dec 2008

General Description

The LF198/LF298/LF398 are monolithic sample-and-hold circuits which utilize BI-FET technology to obtain ultra-high dc accuracy with fast acquisition of signal and low droop rate. Operating as a unity gain follower, dc gain accuracy is 0.002% typical and acquisition time is as low as 6 μs to 0.01%. A bipolar input stage is used to achieve low offset voltage and wide bandwidth. Input offset adjust is accomplished with a single pin, and does not degrade input offset drift. The wide bandwidth allows the LF198 to be included inside the feedback loop of 1 MHz op amps without having stability problems. Input impedance of 10¹⁰Ohm allows high source impedances to be used without degrading accuracy.

P-channel junction FET's are combined with bipolar devices in the output amplifier to give droop rates as low as 5 mV/min with a 1 μF hold capacitor. The JFET's have much lower noise than MOS devices used in previous designs and do not exhibit high temperature instabilities. The overall design guarantees no feed-through from input to output in the hold mode, even for input signals equal to the supply voltages.


Reliability Metrics

Part Number	Process	EFR Reject	EFR Sample Size	PPM	LTA Rejects	LTA Device Hours	FITS	MTTF (Hours)
LF398 MDC	BIFET	0	12335	0	0	975000	4	276658912
LF398 MWC	BIFET	0	12335	0	0	975000	4	276658912
LF398AH	BIFET	0	12335	0	0	975000	4	276658912
LF398AN	BIFET	0	12335	0	0	975000	4	276658912
LF398H	BIFET	0	12335	0	0	975000	4	276658912
LF398M	BIFET	0	12335	0	0	975000	4	276658912
LF398MX	BIFET	0	12335	0	0	975000	4	276658912
LF398N	BIFET	0	12335	0	0	975000	4	276658912

Note: The Early Failure Rates (EFR) were calculated as point estimate PPM based on rejects and sample size for EFR. The Long Term Failure Rates were calculated at 60% confidence using the Arrhenius equation at 0.7eV activation energy and derating the assumed stress temperature of 150°C to an application temperature of 55°C.

For more information on Reliability Metrics, please click [here](#).

Application Notes

Title	Size in Kbytes	Date	
AN-298: Application Note 298 Isolation Techniques for Signal Conditioning	379 Kbytes	2-Oct-02	Download
AN-775: Specifications and Architectures of Sample-and-Hold Amplifiers	111 Kbytes	5-Aug-95	Download
AN-775 (Japanese): Specifications and Architectures of Sample-and-Hold Amplifiers 本サイトの日本語アプリケーション・ノートは最新版でない場合があります。ご検討およびご採用にあたっては、必ず最新の英語版アプリケーション・ノートをご確認ください。	251 Kbytes		ダウンロード
AN-266: Application Note 266 Circuit Applications of Sample-Hold Amplifiers	508 Kbytes	2-Oct-02	Download
AN-258: Application Note 258 Data Acquisition Using the ADC0816 and ADC0817 8-Bit A/D Converter with On-Chip 16 Channel Multiplexer	683 Kbytes	4-Oct-04	Download
AN-301: Application Note 301 Signal Conditioning for Sophisticated Transducers	579 Kbytes	2-Oct-02	Download
AN-247: Application Note 247 Using the ADC0808/ADC0809 8-Bit μ P Compatible A/D Converters with 8-Channel Analog Multiplexer	547 Kbytes	3-Oct-02	Download

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More Application Notes

Title	Size in Kbytes	Date	
AN-292: Application Note 292 Applications of the LM3524 Pulse-Width-Modulator	239 Kbytes	3-Oct-02	Download

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